

Search Notes

Application/Control No.

10/511,097

Examiner

Mark A. Chapman

Applicant(s)/Patent under
Reexamination

UENO ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	108.2	7/7/2005	MC
	108.4		
	108.21		
558	488		
568	735		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/7/2005	MC
stic search		
reviewed related applications		